



## TO-263-2L Plastic-Encapsulate MOSFETS

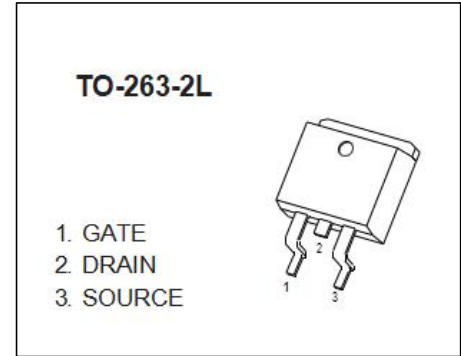
### CCMA160N04S N-Channel Power MOSFET

V <sub>DSS</sub>	R <sub>DS(ON)</sub> (Typ.)	I <sub>D</sub>
40 V	1.8mΩ@10V	160A

#### DESCRIPTION

The CCMA160N04S provides excellent R<sub>DS(ON)</sub> with low gate charge.

It can be used in a wide variety of applications.



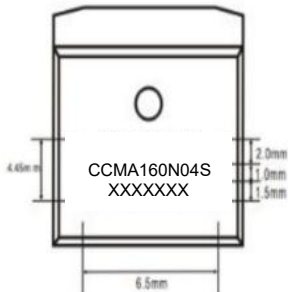
#### FEATURES

- Power MOSFET for automotive applications
- 100% Avalanche tested
- 175°C operating temperature
- Green Product (RoHS compliant)
- AEC Q101 Qualified

#### APPLICATIONS

- Electronic water pump
- Electric steering
- ESC

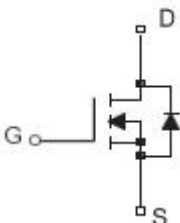
#### MARKING



CCMA160N04S =Part No.

XXXXXXX = Code

#### EQUIVALENT CIRCUIT



**ABSOLUTE MAXIMUM RATINGS( $T_c=25^{\circ}\text{C}$  unless otherwise noted)**

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup>	$I_D$	160	A
Pulsed Drain Current	$I_{DM}$	640	A
Single Pulse Avalanche Energy <sup>2</sup>	$E_{AS}$	812	mJ
Total Power Dissipation	$P_D$	163	W
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.92	$^{\circ}\text{C}/\text{W}$
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~ +175	$^{\circ}\text{C}$
Soldering Temperature , for 10S(1.6mm from case)	-	260	$^{\circ}\text{C}$

**Notes:**

1. Current is limited by bondwire, with an  $R_{\theta JC}=0.92^{\circ}\text{C}/\text{W}$  the chip is able to carry 226A at  $25^{\circ}\text{C}$
2. Limited by  $T_{Jmax}$ , starting  $T_J = 25^{\circ}\text{C}$ ,  $L = 0.5\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 57\text{A}$ ,  $V_{GS} = 10\text{V}$ .

# MOSFET ELECTRICAL CHARACTERISTICS

TC=25°C unless otherwise specified

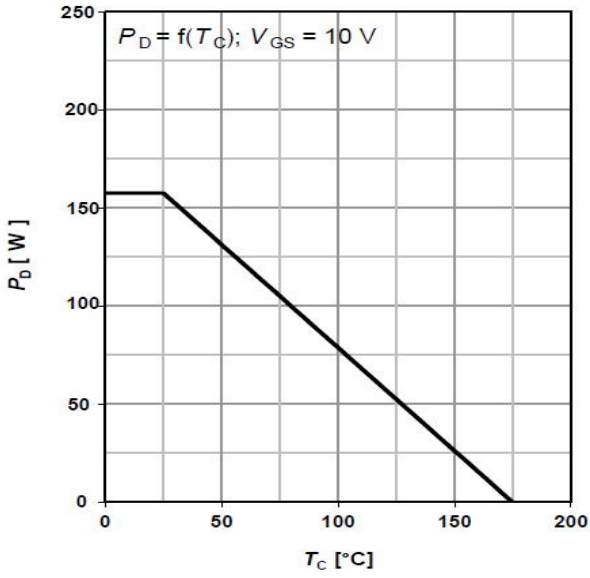
Parameter	Symbol	Test Condition	Min	Type	Max	Unit
<b>Off characteristics</b>						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	40			V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 32V, V_{GS} = 0V$			1	$\mu A$
Gate-body leakage current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
<b>On characteristics</b>						
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	2.7	4.0	V
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 80A$		1.8	2.2	m $\Omega$
Transconductance	$g_{fs}$	$V_{DS} = 10V, I_D = 10A$		65		S
<b>Dynamic characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$		4972	6464	pF
Output Capacitance	$C_{oss}$			996	1300	
Reverse Transfer Capacitance	$C_{rss}$			32	42	
Gate resistance	$R_g$	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		1.6		$\Omega$
<b>Switching characteristics<sup>2</sup></b>						
Total Gate Charge	$Q_g$	$V_{DD} = 32V, V_{GS} = 0-10V, I_D = 160A$		98	120	nC
Gate-Source Charge	$Q_{gs}$			52	64	
Gate-Drain Charge	$Q_{gd}$			16	30	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 20V, V_{GS} = 10V, I_D = 160A, R_G = 3.5\Omega$		25		ns
Turn-on rise time	$t_r$			14		
Turn-off delay time	$t_{d(off)}$			32		
Turn-off fall time	$t_f$			32		
<b>Drain-source Diode characteristics</b>						
Diode Forward Voltage <sup>2</sup>	$V_{SD}$	$V_{GS} = 0V, I_S = 80A, T_J = 25^\circ C$		0.8	1.2	V
Continuous Source Current <sup>1</sup>	$I_S$	$T_C = 25^\circ C$			160	A
Pulsed drain-source diode forward current	$I_{SM}$	—			640	A
Reverse recovery time	$t_{rr}$	$V_R = 20V, I_F = 50A, di/dt = 100A/\mu s$		55		ns
Reverse recovery charge	$Q_{rr}$			58		nC

Note :

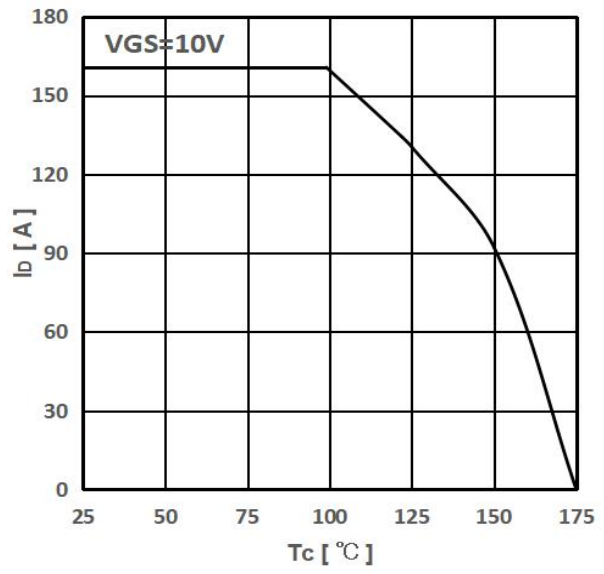
1. Current is limited by bondwire, with an  $R_{\theta JC} = 0.92^\circ C/W$  the chip is able to carry 226A at 25°C.
2. Defined by design. Not subject to production test.

# Typical Characteristics

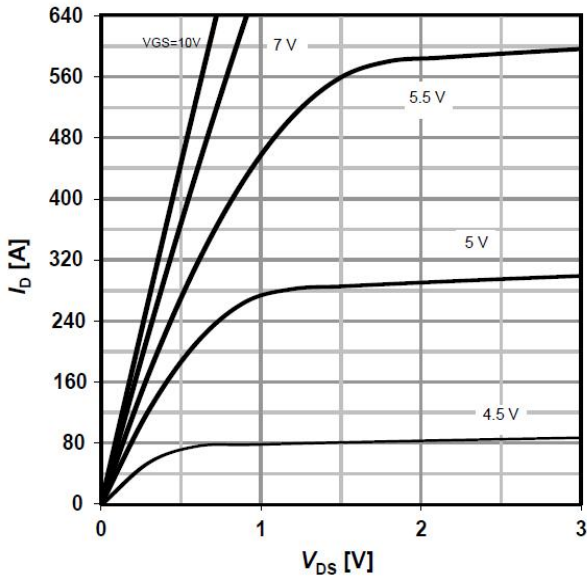
PD -- Tc



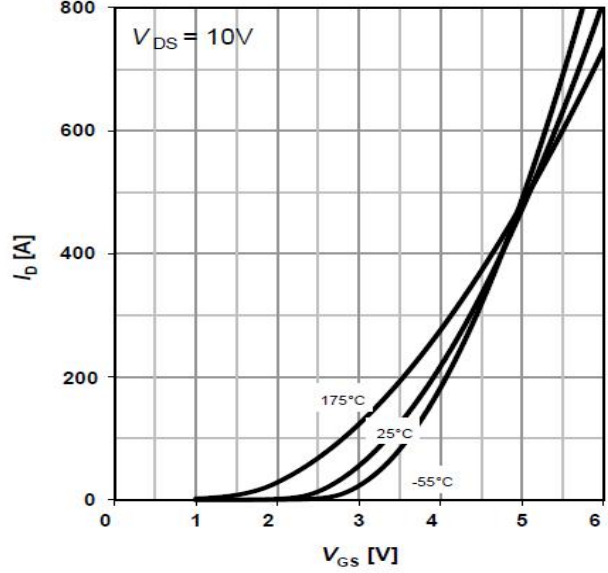
ID -- Tc



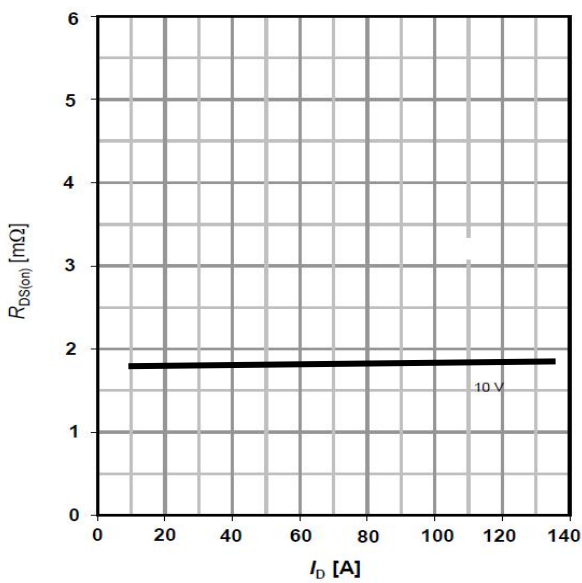
ID -- VDS



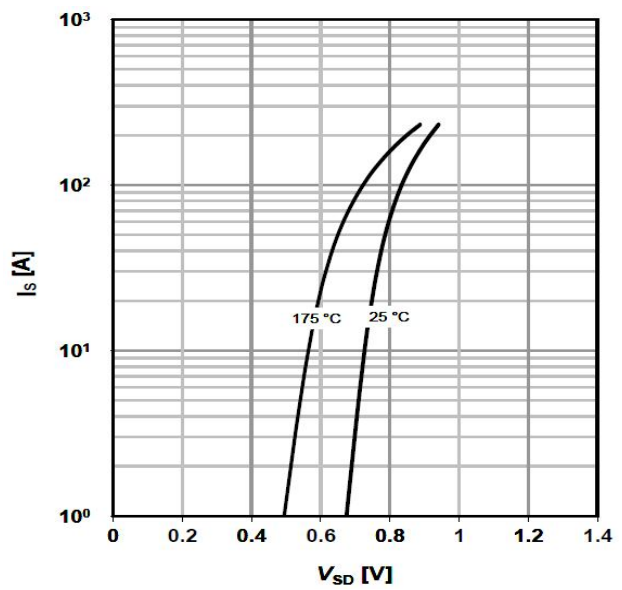
ID -- VGS



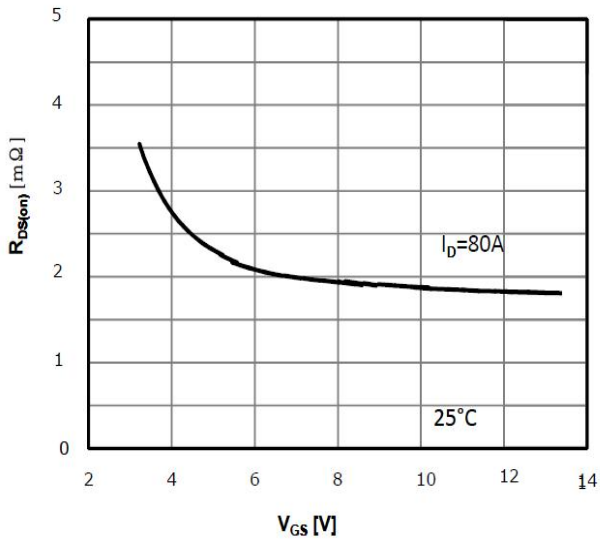
RDS(on) -- ID



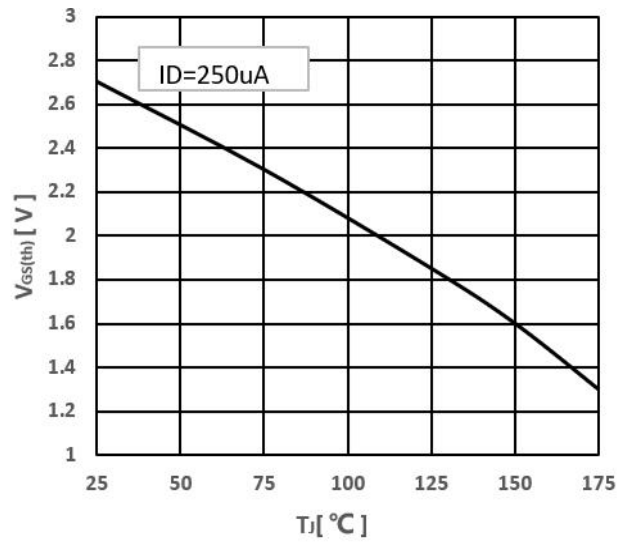
IS -- VSD



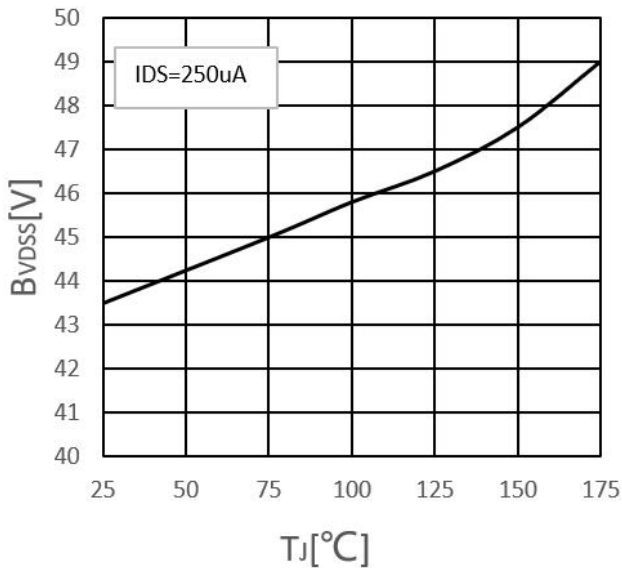
**RDS(on) -- VGS**



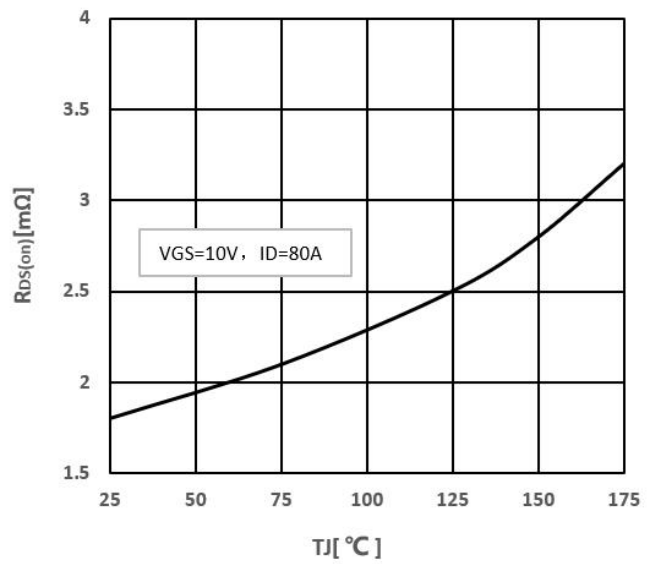
**Threshold Voltage**



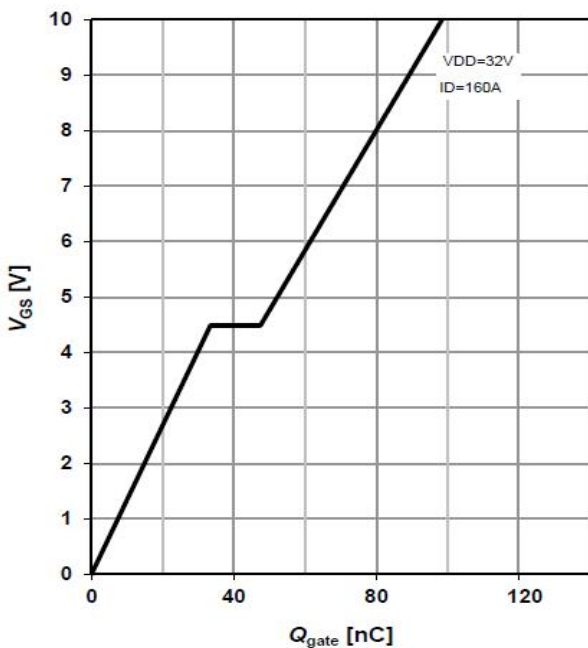
**Drain-source breakdown voltage**



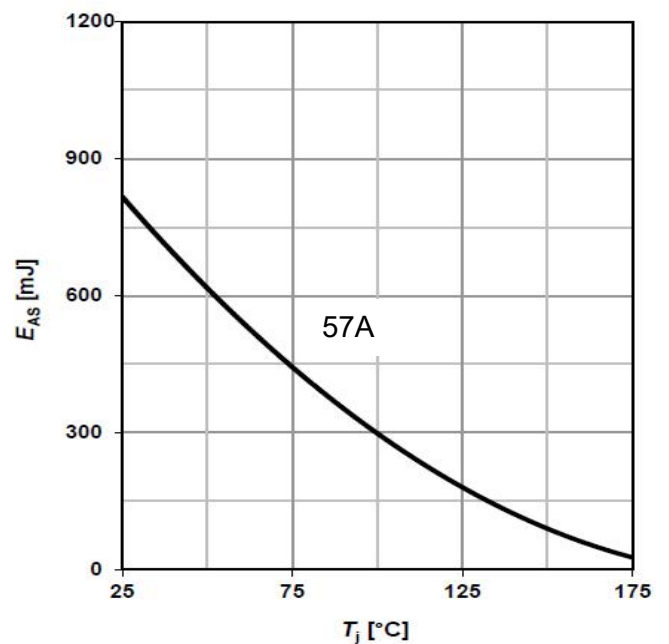
**RDS (on) -- TJ**



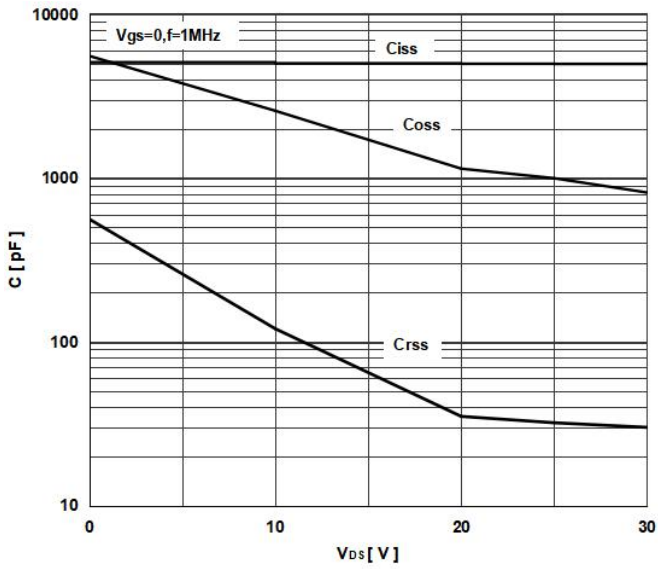
**Typ.gate charge**



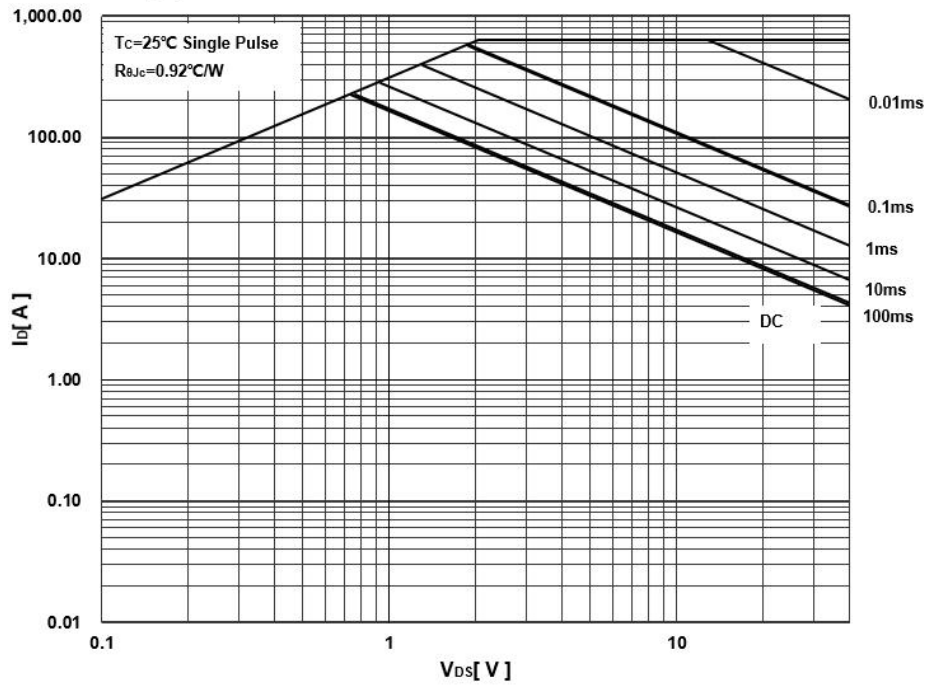
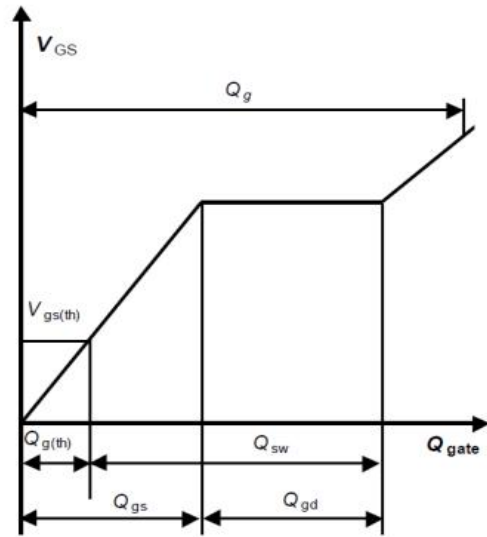
**Avalanche energy**



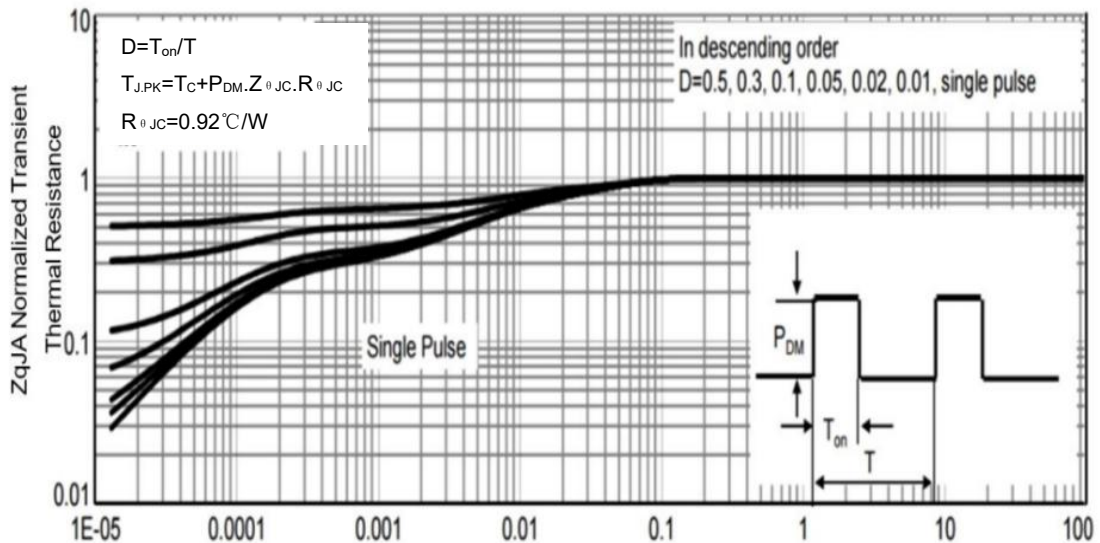
### Typ. capacitance



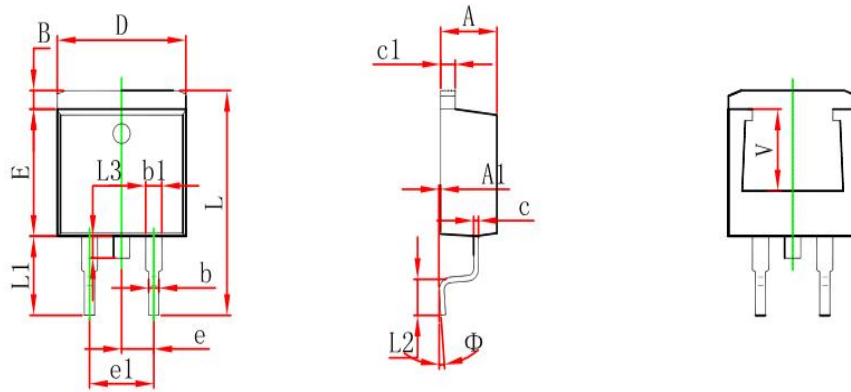
### Gate charge waveforms



### Normalized Thermal Transient Impedance

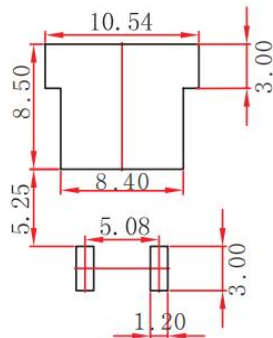


## TO-263-2L Package Outline Dimensions



Symbol	Dimensions in Millimeters		Dimensions in Inches	
	Min.	Max.	Min.	Max.
A	4.470	4.670	0.176	0.184
A1	0.000	0.150	0.000	0.006
B	1.120	1.420	0.044	0.056
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.310	0.530	0.012	0.021
c1	1.170	1.370	0.046	0.054
D	10.010	10.310	0.394	0.406
E	8.500	8.900	0.335	0.350
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
L	14.940	15.500	0.588	0.610
L1	4.950	5.450	0.195	0.215
L2	2.340	2.740	0.092	0.108
L3	1.300	1.700	0.051	0.067
Φ	0°	8°	0°	8°
V	5.600 REF.		0.220 REF.	

## TO-263-2L Suggested Pad Layout



### Note:

1. Controlling dimension: in millimeters.
2. General tolerance: 0.5mm.
3. The pad layout is for reference purposes only.

### NOTICE

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Date of change	Rev #	revise content
2023/11/27	A/0	/